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ISO/IEC JTC 1/SGFS
Title: ISO/IEC JTC 1 Special Group on Functional Standardization

Secretariat: NNI (Netherlands)

Title : Draft Minutes of the ISO/IEC JTC1/SGFS Ad Hoc meeting, November 26-27, 1990, Brussels

Source : Secretariat

Status : draft

Note :

Draft minutes
of the ISO/IEC JTC1/SGFS Ad Hoc meeting
26/27 November 1990
Brussels

Attendance: see attached list

1. Opening

The SGFS chairman Mr. Louis Visser opened the meeting at 10.00 h. and welcomed all the participants.

2. Adoption of the agenda

The agenda as proposed in document SGFS N 271 was approved.

3. Roll Call of participants

A short introduction round was held.

4. Review of incoming contributions

Received documents for input:
SGFS N 272 EWOS/EGCT response to SGFS N 213
SGFS N 273 SPAG response to SGFS N 213
SGFS N 277 COS response to SGFS N 213
SGFS N 279 NIST/OIW position on Profile Conformance
SGFS N 280 Japan/POSI comments on SGFS N 213
SGFS N 281 AFNOR comments on SGFS N 213

5. Identification of topics for discussion

It was decided to discuss the following topics:
- Responsibility for Profile Test Specifications
- S-Liaison access beyond SGFS
- PICS Notations
- Scope of Profile Testing
- Profile Configurability

6. Discussion

* Responsibility for Profile Test Specifications

The documents SGFS N 213 (= SC21 N 5085) and N 233 (= SGFS response to SC21 N 5085) were noted.
In N 233 the SGFS accepts the responsibility for Profile Test Specifications and SC21 N 5085 is correct in stating that the OSI test suite standardization is undertaken by SC6 and SC21.
However, the SGFS Ad Hoc meeting considered that it may be misinterpreted in stating that the standardization of the selection and parameterization of these test suites for profile purposes, and the standardization of the specification of additional test cases, is the responsibility of the SGFS. As with an ISP itself, this is the responsibility of the submitting organization.
These views were stated in a separate document (SGFS N 292) for consideration by the membership of SGFS.

* S-Liaison access beyond SGFS

The JTC1 Advisory Group has specified that the "S-Liaison" status is restricted to participation in SGFS. The preferred approach is that contributions to JTC1 (and SCs or WGs) have to be submitted through National Bodies.
In document N 233 the SGFS introduced to SC21 the possibility that S-Liaison views might be expressed to SC21 through liaison via the SGFS when the contributions are considered and harmonized by the full SGFS during a plenary meeting.
However, because the SGFS meets only once per year, the Ad Hoc meeting recommends that the SGFS define procedures for handling such contributions between meetings.
It was proposed to identify specific projects in other groups for special treatment. This means that the SGFS should, at its yearly meeting, identify and agree to these projects when contribution from SGFS could help facilitate the work. If a contribution from an SGFS member or liaison to the SGFS is specified for a "pre-approved" project and if this contribution is internationally harmonized (i.e. by TLFF or RWCC), then the contribution can be forwarded to the appropriate project directly by the SGFS Secretariat. The formal status of the contribution can be "International Harmonized Expert Paper".
This proposal to the SGFS membership is expressed in document SGFS N 290.

* PICS Notations

Chapter 2 "The nature of Profile conformance" of document N 213 has been discussed.
SC21 offered the possibility for a 2 character notation within a single status column for the profile requirements (e.g. "mo" which means mandatory to be implemented, optional to be used).
It appeared that some different interpretations existed of concepts as "Optional to be used", "Excluded", "Out of Scope" etc.
It was stated that if you use the existing characters on the right

way then you do not need a two character notation.
As a response to chapter 2 the Ad Hoc meeting expressed its views within a liaison statement to SC21/WG1 (document SGFS N 289).

* Scope of Profile Testing

Then chapter 3 of document N 213 on the scope of profile testing gave rise to a wide ranging discussion on the meaning of "Profile Conformance".
A detailed summary of the considerations made during the meeting is presented in document SGFS N 288. This document will be send to the SC21/WG1 as a liaison contribution from SGFS.

* Profile Configurability

It appeared that two different aspects of profile configurability can be distinguished:
- the means by which an implementation is configured into a given profile, and
- the way a multiprofile product is tested once configured.

Both aspects have been considered and different views have been formulated in document SGFS N 291 which is to be sent to SC21/WG1 as liaison statement.

7. Preparation of conclusions

The output of the Ad Hoc meeting is presented in:

SGFS N 288	Position statement on Scope of Profile Testing
SGFS N 289	Position statement on PICS Notations
SGFS N 290	S-Liaison Access beyond SGFS
SGFS N 291	Position statement on Profile Configurability
SGFS N 292	Responsibility for Profile Test Specification

8. Any other business

None.

9. Closing

The chairman closed the meeting at 16.30 h. on Tuesday 27th, 1991.

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Title: ISO/IEC JTC 1 Special Group on Functional Standardization

Secretariat: NNI (Netherlands)

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26-27 November, 1990
Brussels, Belgium

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